# TOSHIBA

TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (Ultra-High-Speed U-MOSIII)

# **TPCA8022-H**

Switching Regulator Applications Motor Drive Applications DC/DC Converter Applications

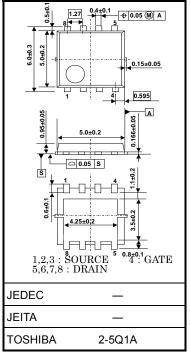
- Small footprint due to a small and thin package
- High speed switching
- Low drain-source ON-resistance

: RDS (ON) = 17 m $\Omega$  (typ.) (V<sub>GS</sub>=10V, I<sub>D</sub>=11A)

- High forward transfer admittance:  $|\,Y_{\rm fs}\,|$  = 46 S (typ.)
- Low leakage current:  $I_{DSS}$  = 10 µA (max) ( $V_{DS}$  = 100 V)
- Enhancement mode:  $V_{th}$  = 2.0 to 4.0 V ( $V_{DS}$  = 10 V,  $I_D$  = 1 mA)

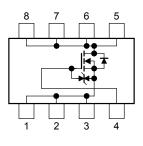
#### Absolute Maximum Ratings (Ta = 25°C)

Characte	ristic	Symbol	Rating	Unit	
Drain-source voltage		V <sub>DSS</sub>	100	V	
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		V <sub>DGR</sub>	100	V	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC (Note 1)	۱ <sub>D</sub>	22	A	
Drain current	Pulsed (Note 1)	I <sub>DP</sub>	66		
Drain power dissipati	on (Tc=25°C)	PD	45	W	
Drain power dissipati	on (t = 10 s) (Note 2a)	PD	2.8	w	
Drain power dissipation (t = 10 s) (Note 2b)		PD	1.6	W	
Single-pulse avalance	he energy (Note 3)	E <sub>AS</sub>	197	mJ	
Avalanche current		I <sub>AR</sub>	22	А	
Repetitive avalanche energy (Note 2a) (Note 4)		E <sub>AR</sub>	3.8	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature	range	T <sub>stg</sub>	–55 to 150	°C	



Weight: 0.069 g (typ.)

## **Circuit Configuration**



Note: For Notes 1 to 4, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

This transistor is an electrostatic-sensitive device. Handle with care.

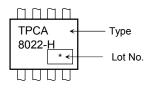
2007-02-09 www.DataSheet4U.com

Unit: mm

## **Thermal Characteristics**

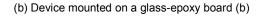
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case (Tc=25°C)	R <sub>th (ch-c)</sub>	2.78	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	44.6	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R <sub>th (ch-a)</sub>	78.1	°C/W

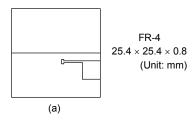
## Marking (Note 5)

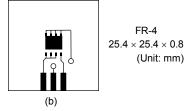


Note 1: The channel temperature should not exceed 150°C during use.

Note 2: (a) Device mounted on a glass-epoxy board (a)







Note 3:  $V_{DD} = 50 \text{ V}$ ,  $T_{ch} = 25^{\circ}C$  (initial), L = 0.5 mH,  $R_G = 25 \Omega$ ,  $I_{AR} = 22 \text{ A}$ 

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: \* Weekly code: (Three digits)



Week of manufacture

\_ (01 for first week of year, continuing up to 52 or 53)

Year of manufacture
 (The last digit of the calendar year)

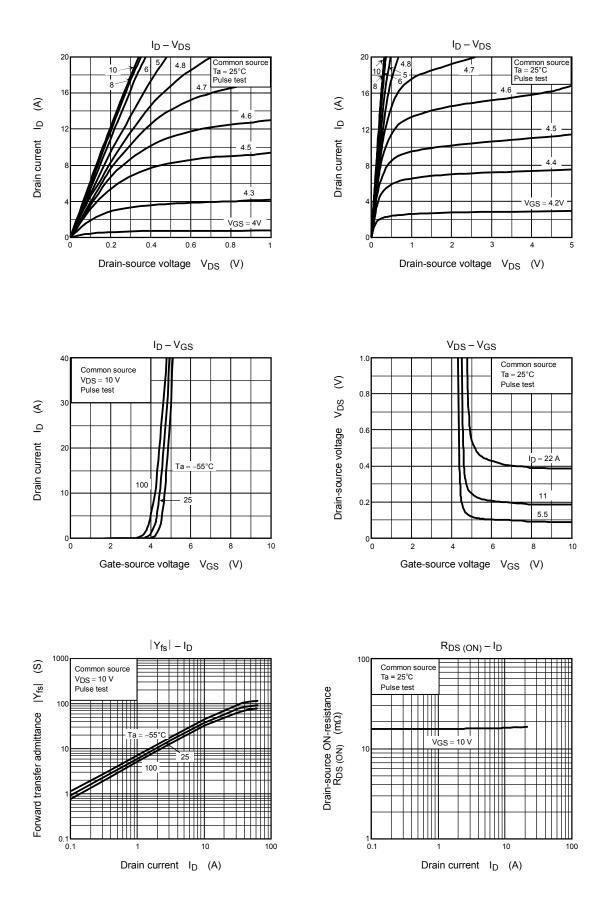
## Electrical Characteristics (Ta = 25°C)

Ch	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ate leakage current		$V_{GS}=\pm 16~V,~V_{DS}=0~V$	_	_	±10	μA
Drain cutoff curre	ent	I <sub>DSS</sub>	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_		10	μA
Drain-source bre	akdown voltage	V (BR) DSS			_	V	
Gate threshold v	oltage	V <sub>th</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	2.0		4.0	V
Drain-source ON	-resistance	R <sub>DS (ON)</sub>	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 11 \text{ A}$	_	17	26	mΩ
Forward transfer		$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 11 \text{ A}$	23	46	_	S	
Input capacitance Reverse transfer capacitance		C <sub>iss</sub>		_	2330		pF
		C <sub>rss</sub>		_	110	_	
Output capacitar	ice	C <sub>oss</sub>	$V_{DS} = 10 V, V_{GS} = 0 V, f = 1 MHz$		420		
Gate-Resistance		Rg			1.5		Ω
Switching time	Rise time	tr	$V_{GS} \stackrel{10}{}_{0}V \qquad I_{D} = 11 A$	_	4.8	_	
	Turn-on time	t <sub>on</sub>		_	14	_	
	Fall time	t <sub>f</sub>		_	6.7	_	ns
	Turn-off time	t <sub>off</sub>	$V_{DD}\simeq 50~V \label{eq:VDD}$ Duty $\leq$ 1%, $t_W=10~\mu s$	_	42	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 80 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 22 \text{ A}$		38	_	nC
Gate-source charge 1		Q <sub>gs1</sub>			9.8	_	
Gate-drain ("Miller") charge		Q <sub>gd</sub>		_	10	_	
Gate switch charge		Q <sub>SW</sub>		_	14	_	

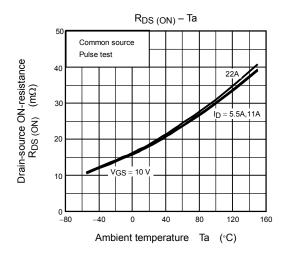
## Source-Drain Ratings and Characteristics (Ta = 25°C)

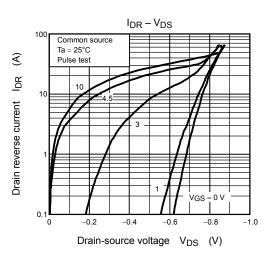
Character	istic	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse	I <sub>DRP</sub>	—	_	_	66	А
Forward voltage (diode)		V <sub>DSF</sub>	$I_{DR}=22~\text{A},~V_{GS}=0~\text{V}$	_		-1.2	V

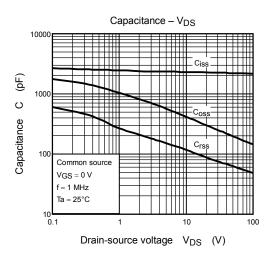
# TOSHIBA

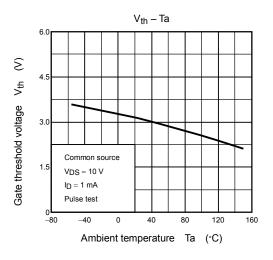


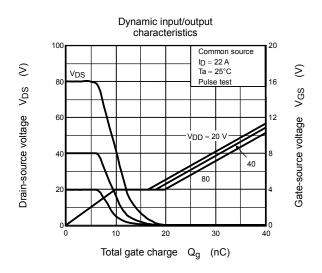
## **TOSHIBA**

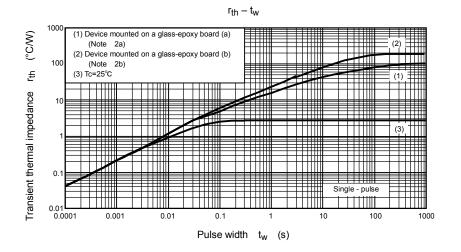


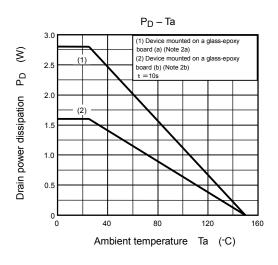


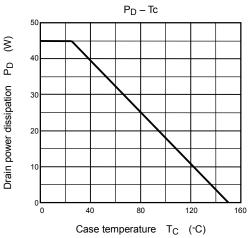


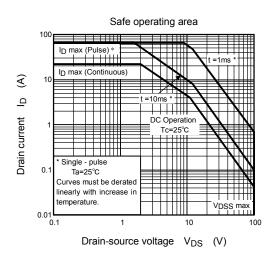












## **RESTRICTIONS ON PRODUCT USE**

070122EAA

- The information contained herein is subject to change without notice. 021023\_D
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
  In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc. 021023\_A
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk. 021023\_B
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations. 060106\_Q
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties. 070122\_C